

MOSFET – Power, Dual, N-Channel, for 3-Cells Lithium-ion Battery Protection, WLCSP8

30 V, 2.6 mΩ, 30 A

EFC4C002NL

This N-Channel Power MOSFET is produced using onsemi trench technology, which is specifically designed to minimize gate charge and ultra low on resistance.

This device is suitable for applications of Drone or Notebook PC.

Features

- Ultra Low On-Resistance
- Low Gate Charge
- Common-Drain Type
- These Device is Pb-Free, Halogen Free and is RoHS Compliant

Applications

• 3-Cells Lithium-ion Battery Charging and Discharging Switch

SPECIFICATIONS

ABSOLUTE MAXIMUM RATINGS at $T_A = 25$ °C (Note 1)

Parameter	Symbol	Value	Unit
Source to Source Voltage	V_{SSS}	30	V
Gate to Source Voltage	V_{GSS}	±20	V
Source Current (DC)	I _S	30	Α
Source Current (Pulse) PW ≤ 10 µs, Duty Cycle ≤ 1%	I _{SP}	120	Α
Total Dissipation (Note 1)	P _T	2.6	W
Junction Temperature	Tj	150	°C
Storage Temperature	Tstg	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

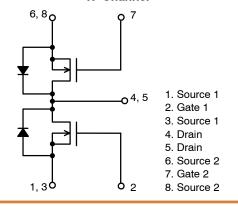
THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction to Ambient (Note 1)	$R_{\theta JA}$	48	°C/W

^{1.} Surface mounted on ceramic substrate (5000 $\text{mm}^2 \times 0.8 \text{ mm}$).

V _{SSS}	R _{SS(on)} Max	I _S Max
30 V	2.6 mΩ @ 10 V	
	3.3 mΩ @ 8 V	30 A
	5.1 mΩ @ 4.5 V	

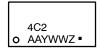
ELECTRICAL CONNECTION N-Channel





WLCSP8 CASE 567MC

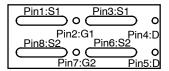
MARKING DIAGRAM



4C2 = Specific Device Code AA = Assembly Location

Y = Year
WW = Work Week
Z = Lot Traceability
= Pb-Free Package

PIN ASSIGNMENT



ORDERING INFORMATION

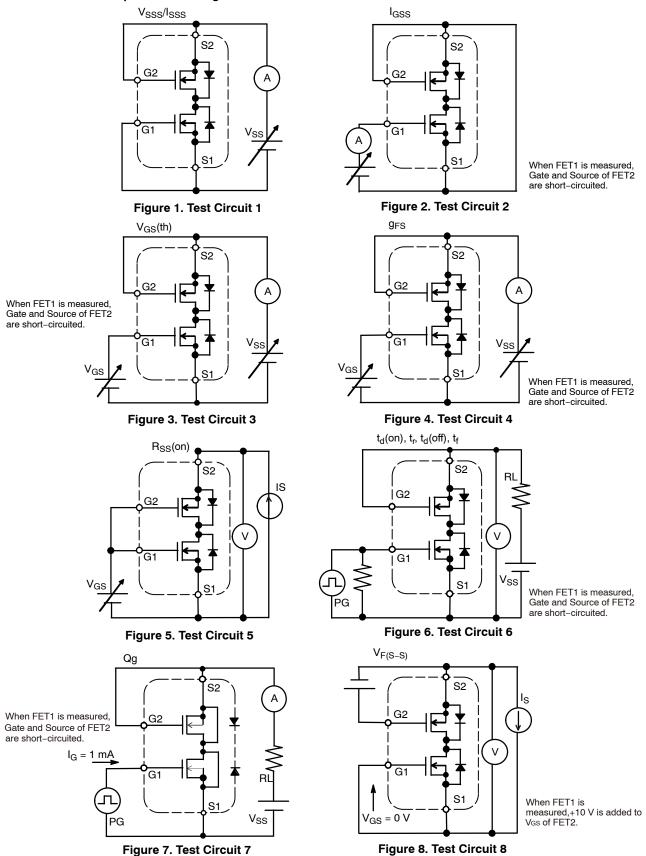
See detailed ordering and shipping information on page 6 of this data sheet.

ELECTRICAL CHARACTERISTICS at $T_A = 25\,^{\circ}C$

			Value			
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Source to Source Breakdown Voltage	V(BR)SSS	I _S = 1 mA, V _{GS} = 0 V Test Circuit 1	30			V
Zero-Gate Voltage Source Current	I _{SSS}	V _{SS} = 24 V, V _{GS} = 0 V Test Circuit 1			1	μΑ
Gate to Source Leakage Current	I _{GSS}	V _{GS} = 20 V, V _{SS} = 0 V Test Circuit 2			200	nA
Gate Threshold Voltage	V _{GS} (th)	V _{SS} = 10 V, I _S = 1 mA Test Circuit 3	1.3		2.2	V
Forward Transconductance	9FS	V _{SS} = 10 V, I _S = 10 A Test Circuit 4		16		S
Static Source to Source On-State Resistance	R _{SS} (on)	V _{GS} = 10 V, I _S = 10 A Test Circuit 5	1.5	2.0	2.6	mΩ
		V _{GS} = 8 V, I _S = 10 A Test Circuit 5	1.6	2.1	3.3	mΩ
		V _{GS} = 4.5 V, I _S = 10 A Test Circuit 5	2.2	2.9	5.1	mΩ
Static Drain to Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V, I _S = 1 A		10		mΩ
Gate Resistance	R_{G}			3		Ω
Turn-ON Delay Time	t _d (on)	V _{SS} = 15 V, V _{GS} = 10 V		40		ns
Rise Time	t _r	I _S = 10 A Test Circuit 6		750		ns
Turn-OFF Delay Time	t _d (off)	1		280		ns
Fall Time	t _f	1		105		ns
Input Capacitance	Ciss	V _{SS} = 15 V, V _{GS} = 0 V, f = 1 MHz		6.200		pF
Total Gate Charge	Qg	V_{SS} = 15 V, V_{GS} = 4.5 V, I_{S} = 15 A Test Circuit 7		45		nC
Forward Source to Source Voltage	V _{F(S-S)}	I _S = 10 A, V _{GS} = 0 V Test Circuit 8		0.75	1.2	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Test circuits are example of measuring FET1 side.

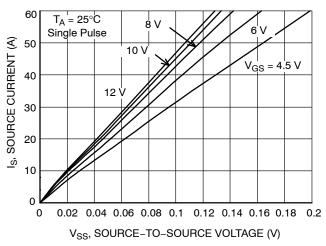


NOTES: When FET2 is measured, the position of FET1 and FET2 is switched.

TYPICAL CHARACTERISTICS

20

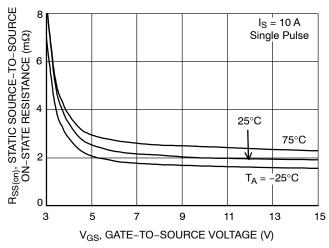
 $V_{SS} = 10 V$



18 Single Pulse SOURCE CURRENT 25°C 12 10 $T_A = 75^{\circ}C$ 8 6 <u>ŵ</u> -25°C 2 0 0 0.5 1.0 1.5 2.0 3.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 9. On-Region Characteristics

Figure 10. Transfer Characteristics



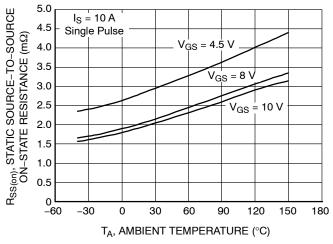


Figure 11. On-Resistance vs. Gate-to-Source Voltage

Figure 12. On-Resistance vs. Temperature

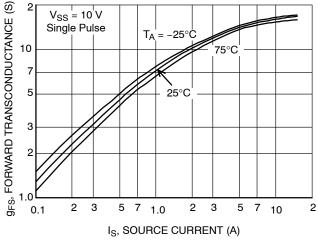


Figure 13. Forward Transconductance vs. Current

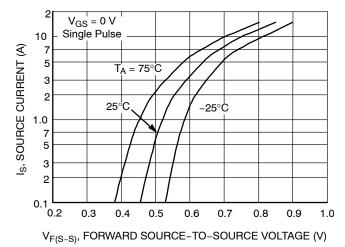


Figure 14. Forward Source-to-Source Voltage vs. Current

TYPICAL CHARACTERISTICS (continued)

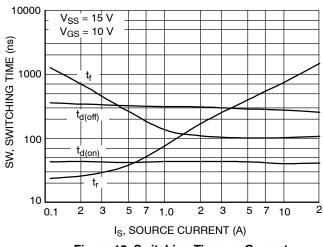


Figure 15. Switching Time vs. Current

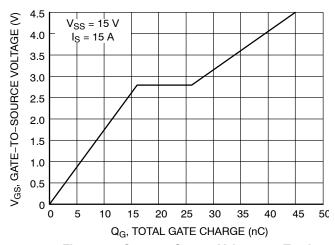


Figure 16. Gate-to-Source Voltage vs. Total Gate Charge

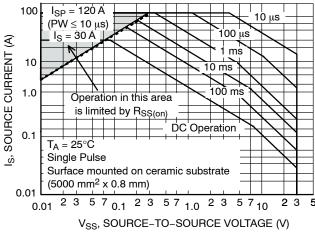


Figure 17. Safe Operating Area

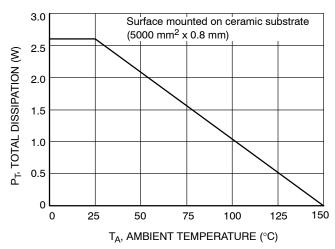


Figure 18. Total Dissipation vs. Temperature

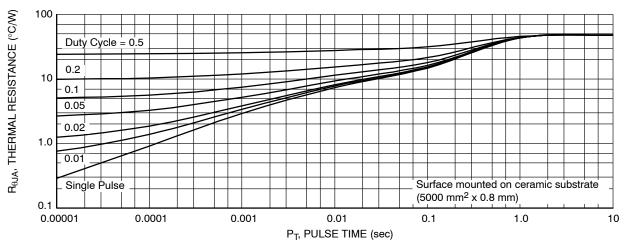


Figure 19. Thermal Response

ORDERING INFORMATION

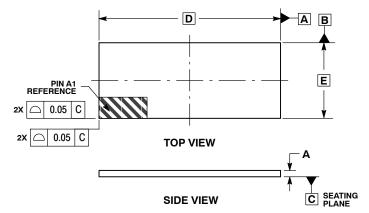
Device	Marking	Package	Shipping (Qty / Packing) [†]
EFC4C002NLTDG	4C2	WLCSP8 6.00x2.50 (Pb-Free / Halogen Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WLCSP8, 6.00x2.50 / EFCP6025-8EGJ-021 CASE 567MC ISSUE O

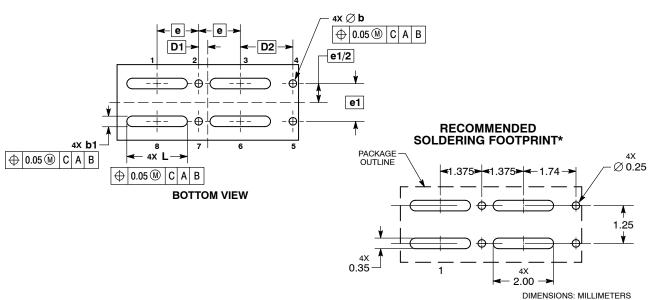
DATE 22 JUL 2015



NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.

	MILLIMETERS		
DIM	MIN MAX		
Α	0.19	0.23	
b	0.22	0.28	
b1	0.32	0.38	
D	5.95	6.05	
D1	0.305 BSC		
D2	1.740 BSC		
E	2.45	2.55	
е	1.375 BSC		
e1	1.25 BSC		
L	1.97	2.03	



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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